## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination YOKOYAMA ET AL. | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			·
	D	US-			
	Ε	US-			
	F	US-			
	G	US-	·		
	Н	US-			
	1	US-	-		
	ſ	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N,	/WO 01/52299 A2	07-2001	WIPO-IB	Hiroshi Kikuchi et al.	H01J 9/00
	0					
	Р	·				
	Q				·	
	R					
	s				•	
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.